ON Semiconductor ${ }^{\text {® }}$

## FDD24AN06LA0

## N-Channel Logic Level PowerTrench ${ }^{\circledR}$ MOSFET 60V, 36A, 24m $\Omega$

## Features

- $r_{D S(O N)}=20 \mathrm{~m} \Omega$ (Typ.), $\mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=36 \mathrm{~A}$
- $\mathrm{Q}_{\mathrm{g}}$ (tot) $=16 \mathrm{nC}$ (Typ.), $\mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}$
- Low Miller Charge
- Low $Q_{R R}$ Body Diode
- UIS Capability (Single Pulse and Repetitive Pulse)
- Qualified to AEC Q101

Formerly developmental type 83547

## Applications

- Motor / Body Load Control
- ABS Systems
- Powertrain Management
- Injection Systems
- DC-DC converters and Off-line UPS
- Distributed Power Architectures and VRMs
- Primary Switch for 12 V and 24 V systems


MOSFET Maximum Ratings $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Ratings | Units |
| :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {DSS }}$ | Drain to Source Voltage | 60 | V |
| $\mathrm{V}_{\mathrm{GS}}$ | Gate to Source Voltage | $\pm 20$ | V |
| ${ }_{\text {I }}$ | Drain Current <br> Continuous ( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ ) | 40 | A |
|  | Continuous ( $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}$ ) | 36 | A |
|  | Continuous ( $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}$ ) | 25 | A |
|  | Continuous ( $\left.\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}, \mathrm{R}_{\theta \mathrm{JA}}=52^{\circ} \mathrm{C} / \mathrm{W}\right)$ | 7.1 | A |
|  | Pulsed | Figure 4 | A |
| E ${ }_{\text {AS }}$ | Single Pulse Avalanche Energy (Note 1) | 32 | mJ |
| $P_{\text {D }}$ | Power dissipation | 75 | W |
|  | Derate above $25^{\circ} \mathrm{C}$ | 0.5 | W/ ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{J},} \mathrm{T}_{\text {STG }}$ | Operating and Storage Temperature | -55 to 175 | ${ }^{\circ} \mathrm{C}$ |

## Thermal Characteristics

| $\mathrm{R}_{\text {өJC }}$ | Thermal Resistance Junction to Case TO-252 | 2.0 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| :--- | :--- | :---: | :---: |
| $\mathrm{R}_{\text {ӨJA }}$ | Thermal Resistance Junction to Ambient TO-252 | 100 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{R}_{\text {өJA }}$ | Thermal Resistance Junction to Ambient TO-252, $1 \mathrm{in}^{2}$ copper pad area | 52 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at: http://www.aecouncil.com/

All ON Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification

## Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
| :---: | :---: | :---: | :---: | :---: | :---: |
| FDD24AN06LA0 | FDD24AN06LA0 | TO-252AA | 330 mm | 16 mm | 2500 units |

Electrical Characteristics $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Off Characteristics |  |  |  |  |  |  |
| B ${ }^{\text {VDSS }}$ | Drain to Source Breakdown Voltage | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ | 60 | - | - | V |
| IDSS | Zero Gate Voltage Drain Current | $\mathrm{V}_{\mathrm{DS}}=50 \mathrm{~V}$ | - | - | 1 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ $\mathrm{~T}_{\mathrm{C}}=150^{\circ} \mathrm{C}$ | - | - | 250 |  |
| IGSS | Gate to Source Leakage Current | $\mathrm{V}_{\mathrm{GS}}= \pm 20 \mathrm{~V}$ | - | - | $\pm 100$ | nA |

On Characteristics

| $\mathrm{V}_{\mathrm{GS} \text { (TH) }}$ | Gate to Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ | 1 | - | 2 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ${ }^{\text {r }}$ SS(ON) | Drain to Source On Resistance | $\mathrm{I}_{\mathrm{D}}=40 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=10 \mathrm{~V}$ | - | 0.016 | 0.019 | $\Omega$ |
|  |  | $\mathrm{I}_{\mathrm{D}}=36 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=5 \mathrm{~V}$ | - | 0.020 | 0.024 |  |
|  |  | $\begin{aligned} & \mathrm{I}_{\mathrm{D}}=36 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=5 \mathrm{~V}, \\ & \mathrm{~T}_{\mathrm{J}}=175^{\circ} \mathrm{C} \end{aligned}$ | - | 0.047 | 0.056 |  |

Dynamic Characteristics

| $\mathrm{C}_{\text {ISS }}$ | Input Capacitance | $\begin{aligned} & -V_{D S}=25 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ | - | 1850 | - | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{CoSS}^{\text {coser }}$ | Output Capacitance |  | - | 180 | - | pF |
| $\mathrm{C}_{\text {RSS }}$ | Reverse Transfer Capacitance |  |  | 75 | - | pF |
| $\mathrm{Q}_{\mathrm{g} \text { (TOT) }}$ | Total Gate Charge at 5V | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to 5 V |  | 16 | 21 | nC |
| $\mathrm{Q}_{\mathrm{g} \text { (TH) }}$ | Threshold Gate Charge | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}$ to $1 \mathrm{~V} \mathrm{~V}_{\mathrm{DD}}=30 \mathrm{~V}$ | - | 1.8 | 2.4 | nC |
| $\mathrm{Q}_{\mathrm{gs}}$ | Gate to Source Gate Charge | $\begin{aligned} & \mathrm{I}_{\mathrm{D}}=36 \mathrm{~A} \\ & \mathrm{I}_{\mathrm{g}}=1.0 \mathrm{~mA} \end{aligned}$ | - | 6.3 | - | nC |
| $\mathrm{Q}_{\mathrm{gs} 2}$ | Gate Charge Threshold to Plateau |  | - | 4.5 | - | nC |
| $\mathrm{Q}_{\mathrm{gd}}$ | Gate to Drain "Miller" Charge |  | - | 5.0 | - | nC |

Switching Characteristics ( $\mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}$ )

| $\mathrm{t}_{\mathrm{ON}}$ | Turn-On Time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=30 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=36 \mathrm{~A} \\ & \mathrm{~V}_{\mathrm{GS}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{GS}}=9.1 \Omega \end{aligned}$ | - | - | 195 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{d}(\mathrm{ON})}$ | Turn-On Delay Time |  | - | 12 | - | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Rise Time |  | - | 118 | - | ns |
| $\mathrm{t}_{\text {d(OFF) }}$ | Turn-Off Delay Time |  | - | 26 | - | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Fall Time |  | - | 41 | $\checkmark$ | ns |
| toff | Turn-Off Time |  | - | - | 101 | ns |

Drain-Source Diode Characteristics

| $\mathrm{V}_{\mathrm{SD}}$ | Source to Drain Diode Voltage | $\mathrm{I}_{\mathrm{SD}}=36 \mathrm{~A}$ | - | - | 1.25 | V |
| :--- | :--- | :--- | :--- | :--- | :--- | :---: |
|  |  | $\mathrm{I}_{\mathrm{SD}}=18 \mathrm{~A}$ | - | - | 1.0 | V |
| $\mathrm{t}_{\mathrm{rr}}$ | Reverse Recovery Time | $\mathrm{I}_{\mathrm{SD}}=36 \mathrm{~A}, \mathrm{dl}_{\mathrm{SD}} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ | - | - | 34 | ns |
| $\mathrm{Q}_{\mathrm{RR}}$ | Reverse Recovered Charge | $\mathrm{I}_{\mathrm{SD}}=36 \mathrm{~A}, \mathrm{dl}_{\mathrm{SD}} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ | - | - | 30 | nC |

Notes:
1: Starting $T_{J}=25^{\circ} \mathrm{C}, \mathrm{L}=80 \mu \mathrm{H}, \mathrm{I}_{\mathrm{AS}}=28 \mathrm{~A}$.

Typical Characteristics $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 1. Normalized Power Dissipation vs Ambient Temperature


Figure 2. Maximum Continuous Drain Current vs Case Temperature


Figure 3. Normalized Maximum Transient Thermal Impedance


Figure 4. Peak Current Capability

Typical Characteristics $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 5. Forward Bias Safe Operating Area


NOTE: Refer to ON Semiconductor Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching Capability


Figure 8. Saturation Characteristics


Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature

Typical Characteristics $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise noted


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature


Figure 13. Capacitance vs Drain to Source Voltage


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature


Figure 14. Gate Charge Waveforms for Constant Gate Current

## Test Circuits and Waveforms



Figure 15. Unclamped Energy Test Circuit


Figure 17. Gate Charge Test Circuit


Figure 19. Switching Time Test Circuit


Figure 16. Unclamped Energy Waveforms


Figure 18. Gate Charge Waveforms


Figure 20. Switching Time Waveforms

## Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, $\mathrm{T}_{\mathrm{JM}}$, and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, $\mathrm{P}_{\mathrm{DM}}$, in an application. Therefore the application's ambient temperature, $\mathrm{T}_{\mathrm{A}}\left({ }^{\circ} \mathrm{C}\right)$, and thermal resistance $\mathrm{R}_{\text {日JA }}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ must be reviewed to ensure that $T_{J M}$ is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$
\begin{equation*}
P_{D M}=\frac{\left(T_{J M}-T_{A}\right)}{R_{\theta J A}} \tag{EQ.1}
\end{equation*}
$$

In using surface mount devices such as the TO-252 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of $P_{D M}$ is complex and influenced by many factors:

1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
2. The number of copper layers and the thickness of the board.
3. The use of external heat sinks.
4. The use of thermal vias.
5. Air flow and board orientation.
6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.
ON Semiconductor provides thermal information to assist the designer's preliminary application evaluation. Figure 21
defines the $R_{\theta J A}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with $10 z$ copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the ON Semiconductor device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$
\begin{align*}
& R_{\theta J A}=33.32+\frac{23.84}{(0.268+\text { Area })}  \tag{EQ.2}\\
& R_{\theta J A}=33.32+\frac{154}{(1.73+\text { Area })}
\end{align*} \quad \text { (EQ. 2) }
$$

## PSPICE Electrical Model

.SUBCKT FDD24ANO6LAO 213 ; rev January 2004
Ca 128 4.7e-10
Cb 15 14 8.7e-10
Cin 68 1.75e-9
Dbody 75 DbodyMOD
Dbreak 511 DbreakMOD
Dplcap 105 DplcapMOD
Ebreak 117171864.8
Eds 148581
Egs 138681
Esg 610681
Evthres 6211981
Evtemp 20618221
It 8171
Lgate 19 3.35e-9
Ldrain 25 1.0e-9
Lsource 37 2.46e-9
RLgate 1933.5
RLdrain 2510
RLsource 3724.6
Mmed 16688 MmedMOD
Mstro 16688 MstroMOD
Mweak 162188 MweakMOD
Rbreak 1718 RbreakMOD 1
Rdrain 5016 RdrainMOD 3.8e-3
Rgate 9203.42


RSLC1 551 RSLCMOD 1e-6
RSLC2 550 1e3
Rsource 87 RsourceMOD 8e-3
Rvthres 228 RvthresMOD 1
Rvtemp 1819 RvtempMOD 1
S1a 612138 S1AMOD
S1b 1312138 S1BMOD
S2a 6151413 S2AMOD
S2b 13151413 S2BMOD
Vbat 2219 DC 1
ESLC 5150 VALUE $=\left\{(\mathrm{V}(5,51) / \operatorname{ABS}(\mathrm{V}(5,51)))^{*}\left(\operatorname{PWR}\left(\mathrm{~V}(5,51) /\left(1 \mathrm{e}-6^{*} 150\right), 2.5\right)\right)\right\}$
.MODEL DbodyMOD D (IS=9.3E-12 RS=2.7e-3 IKF=0.9 TRS1=1.5e-3 TRS2=2e-7

+ CJO=6.2e-10 M=0.57 TT=1.2e-8 XTI=1.2)
.MODEL DbreakMOD D (RS=1.1 TRS1=2.4e-3 TRS2=-2.0e-5)
.MODEL DplcapMOD D (CJO=4.9e-10 IS $=1 \mathrm{e}-30 \mathrm{~N}=10 \mathrm{M}=0.58$ )
.MODEL MmedMOD NMOS (VTO=1.7 KP=2.2 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=3.42 T_ABS=25)
.MODEL MstroMOD NMOS (VTO=2.04 KP=69 IS=1e-30 N=10 TOX=1 L=1u W=1u T_ABS=25)
.MODEL MweakMOD NMOS (VTO=1.45 KP=0.05 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=34.2 RS=0.1 T_ABS=25)
.MODEL RbreakMOD RES (TC1=8.0e-4 TC2=-8.3e-7)
.MODEL RdrainMOD RES (TC1=1.0e-2 TC2=3.7e-5)
.MODEL RSLCMOD RES (TC1=4.5e-3 TC2=6.5e-6)
.MODEL RsourceMOD RES (TC1=8.0e-3 TC2=1.0e-6)
.MODEL RvthresMOD RES (TC1=-2.9e-3 TC2=-9.0e-6)
.MODEL RvtempMOD RES (TC1 $=-2.0 \mathrm{e}-3$ TC2 $=1.0 \mathrm{e}-8$ )
MODEL S1AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-6.0 VOFF=-3.0)
.MODEL S1BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-3.0 VOFF=-6.0)
.MODEL S2AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-0.4 VOFF=0.3)
.MODEL S2BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=0.3 VOFF=-0.4)
.ENDS
Note: For further discussion of the PSPICE model, consult A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.


## SABER Electrical Model

rev January 2004
template FDD24AN06LA0 n2, n1, n3 = m_temp
number m_temp $=25$
electrical n2,n1,n3
\{
var i iscl
dp..model dbodymod $=($ isl $=9.3 \mathrm{e}-12, \mathrm{rs}=2.7 \mathrm{e}-3, \mathrm{ikf}=0.9, \mathrm{trs} 1=1.5 \mathrm{e}-3, \mathrm{trs} 2=2 \mathrm{e}-7, \mathrm{cjo}=6.2 \mathrm{e}-10, \mathrm{~m}=0.57, \mathrm{tt}=1.2 \mathrm{e}-8, \mathrm{xti}=1.2)$
dp..model dbreakmod $=(r s=1.1$, trs $1=2.4 \mathrm{e}-3, \mathrm{trs} 2=-2 \mathrm{e}-5)$
dp..model dplcapmod $=(\mathrm{cjo}=4.9 \mathrm{e}-10$, is $=10 \mathrm{e}-30, \mathrm{nl}=10, \mathrm{~m}=0.58)$
m..model mmedmod $=\left(\right.$ type $=\_\mathrm{n}, \mathrm{vto}=1.7, \mathrm{kp}=2.2$, is $=1 \mathrm{e}-30$, tox=1)
m..model mstrongmod $=\left(\right.$ type $=\_n, \mathrm{vto}=2.04, \mathrm{kp}=69$, is $=1 \mathrm{e}-30$, tox $\left.=1\right)$
m..model mweakmod $=($ type $=\bar{n}$, vto $=1.45, \mathrm{kp}=0.05$, is $=1 \mathrm{e}-30$, tox $=1, r s=0.1$
sw_vcsp..model s1amod $=($ ron $=1 \mathrm{e}-5$, roff $=0.1$, von $=-6.0$, voff $=-3.0)$
sw_vcsp..model s1bmod $=($ ron $=1 \mathrm{e}-5$, roff $=0.1$,von $=-3.0$, voff $=-6.0)$
sw_vcsp..model s2amod $=(r o n=1 e-5$, roff $=0.1$, von $=-0.4$, voff $=0.3)$
sw_vcsp..model s2bmod $=(r o n=1 e-5, r o f f=0.1$, von $=0.3$, voff $=-0.4)$
c.ca $\mathrm{n} 12 \mathrm{n} 8=4.7 \mathrm{e}-10$
c.cb n15 n14 $=8.7 \mathrm{e}-10$
c.cin $n 6 \mathrm{n} 8=1.75 \mathrm{e}-9$
dp.dbody n7 n5 = model=dbodymod dp.dbreak n5 n11 = model=dbreakmod dp.dplcap n10 n5 = model=dplcapmod
spe.ebreak n11 n7 n17 n18 $=64.8 \quad$ GAT
spe.eds n14 n8 n5 n8 $=1$ spe.eds n14 n8 n5 n8 = 1 spe.egs n13 n8 n6 n8 = 1 spe.esg n6 n10 n6 n8 = 1 spe.evthres n6 n21 n19 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1
i.it n8 n17 $=1$
I. Igate n1 n9 $=3.35 \mathrm{e}-9$
I.Idrain n2 n5 = 1.0e-9
I. Isource n3 n7 $=2.46 \mathrm{e}-9$
res.rlgate n1 n9 = 33.5
res.rldrain n2 n5 $=10$
res.rlsource n3 n7 $=24.6$
m.mmed n16 n6 n8 n8 = model=mmedmod, temp=m_temp, $\mathrm{I}=1 \mathrm{u}, \mathrm{w}=1 \mathrm{u}$
m.mstrong n16 n6n8 n8 = model=mstrongmod, temp=m_temp, $\mathrm{l}=1 \mathrm{u}, \mathrm{w}=1 \mathrm{u}$
m.mweak n16 n21 n8 n8 = model=mweakmod, temp=m_temp, $\mid=1 u, w=1 u$
res.rbreak n17 n18 $=1$, tc1 $=8.0 \mathrm{e}-4, \mathrm{tc} 2=-8.3 \mathrm{e}-7$
res.rdrain n50 n16 $=3.8 \mathrm{e}-3$, tc1=1.0e-2,tc2=3.7e-5
res.rgate $\mathrm{n} 9 \mathrm{n} 20=3.42$
res.rslc1 n5 n51 $=1 \mathrm{e}-6$, tc1 $=4.5 \mathrm{e}-3, \mathrm{tc} 2=6.5 \mathrm{e}-6$
res.rslc2 n5 n50 = 1e3
res.rsource n8 n7 $=8 \mathrm{e}-3$, tc1 $=8 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-6$
res.rvthres n22 n8 = 1, tc1 $=-2.9 \mathrm{e}-3$, tc $2=-9.0 \mathrm{e}-6$
res.rvtemp n18 n19 = 1, tc1 $=-2.0 \mathrm{e}-3, \mathrm{tc} 2=1 \mathrm{e}-8$
sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod
v.vbat n22 n19 = dc=1
equations \{
i (n51->n50) +=iscl
iscl: $v(n 51, n 50)=\left((v(n 5, n 51) /(1 e-9+a b s(v(n 5, n 51))))^{*}\left(\left(a b s\left(v(n 5, n 51)^{*} 1 e 6 / 150\right)\right)^{* *} 2.5\right)\right)$
\}

## PSPICE Thermal Model

REV 23 January 2004
FDD24AN06LAOT
CTHERM1 th $63.2 e-5$
CTHERM2 65 4．9e－5
CTHERM3 54 8．0e－5
CTHERM4 43 8．6e－4
CTHERM5 32 2．8e－3
CTHERM6 2 t1 $7.8 \mathrm{e}-2$
RTHERM1 th 6 1．1e－3
RTHERM2 65 1．2e－3
RTHERM3 54 1．4e－3
RTHERM4 430.54
RTHERM5 320.55
RTHERM6 2 tl 0.56

## SABER Thermal Model

SABER thermal model FDD24AN06LAOT template thermal＿model th tl thermal＿c th，tl
\｛
ctherm．ctherm1 th $6=3.2 \mathrm{e}-5$
ctherm．ctherm2 $65=4.9 \mathrm{e}-5$ ctherm．ctherm3 $54=8.0 \mathrm{e}-5$ ctherm．ctherm4 $43=8.6 \mathrm{e}-4$ ctherm．ctherm5 $32=2.8 \mathrm{e}-3$ ctherm．ctherm6 $2 \mathrm{tl}=7.8 \mathrm{e}-2$
rtherm．rtherm1 th $6=1.1 \mathrm{e}-3$
rtherm．rtherm2 $65=1.2 \mathrm{e}-3$
rtherm．rtherm3 $54=1.4 \mathrm{e}-3$
rtherm．rtherm4 $43=0.54$
rtherm．rtherm5 $32=0.55$ rtherm．rtherm6 $2 \mathrm{tl}=0.56$
\}



#### Abstract

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